

<b>Issue Classification</b>		Application No.		Applicant(s)	
		10/005,384		MATSUDA ET AL.	
		Examiner		Art Unit	
		Jinhee J Lee		2831	

ISSUE CLASSIFICATION						
ORIGINAL		CROSS REFERENCE(S)				
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
174	72A	29	868	825	854	857
INTERNATIONAL CLASSIFICATION		439	34			
H	0	1	R	33/00		
	/					
	/					
	/					
	/					
Jinhee Lee (Assistant Examiner) (Date)		Dean A. Reichard DEAN A. REICHARD 9/20/04 SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) (Date)			Total Claims Allowed: 3	
Dawn Evans 9/20/04 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 4	

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R. 1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		61		91
2	2		32		62		92
2	3		33		63		93
4			34		64		94
5			35		65		95
6			36		66		96
3	7		37		67		97
8			38		68		98
9			39		69		99
10			40		70		100
11			41		71		101
12			42		72		102
13			43		73		103
14			44		74		104
15			45		75		105
16			46		76		106
17			47		77		107
18			48		78		108
19			49		79		109
20			50		80		110
21			51		81		111
22			52		82		112
23			53		83		113
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27			57		87		117
28			58		88		118
29			59		89		119
30			60		90		120